

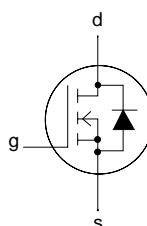
## TrenchMOS™ transistor Logic level FET

## PHP69N03LT, PHB69N03LT, PHD69N03LT

### FEATURES

- 'Trench' technology
- Very low on-state resistance
- Fast switching
- Stable off-state characteristics
- High thermal cycling performance
- Low thermal resistance

### SYMBOL



### QUICK REFERENCE DATA

$V_{DSS} = 25 \text{ V}$

$I_D = 69 \text{ A}$

$R_{DS(ON)} \leq 14 \text{ m}\Omega (V_{GS} = 5 \text{ V})$

$R_{DS(ON)} \leq 12 \text{ m}\Omega (V_{GS} = 10 \text{ V})$

### GENERAL DESCRIPTION

N-channel enhancement mode logic level field-effect power transistor in a plastic envelope using 'trench' technology. The combination of very low on-state resistance and low switching losses make this device the optimum choice in high speed computer motherboard d.c. to d.c. converters.

The PHP69N03LT is supplied in the SOT78 (TO220AB) conventional leaded package.

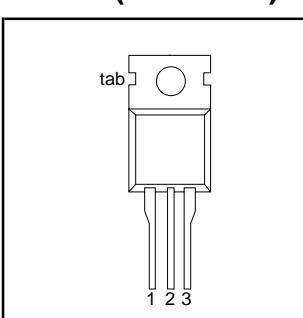
The PHB69N03LT is supplied in the SOT404 surface mounting package.

The PHD69N03LT is supplied in the SOT428 surface mounting package.

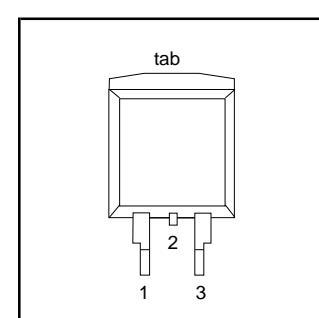
### PINNING

PIN	DESCRIPTION
1	gate
2	drain <sup>1</sup>
3	source
tab	drain

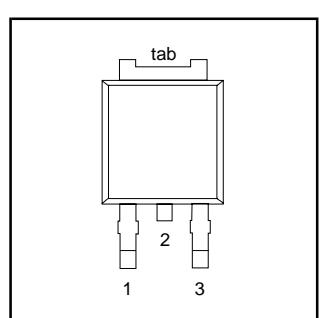
### SOT78 (TO220AB)



### SOT404



### SOT428



### LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DSS}$	Drain-source voltage	$T_j = 25^\circ\text{C}$ to $175^\circ\text{C}$	-	25	V
$V_{DGR}$	Drain-gate voltage	$T_j = 25^\circ\text{C}$ to $175^\circ\text{C}$ ; $R_{GS} = 20 \text{ k}\Omega$	-	25	V
$V_{GS}$	Gate-source voltage		-	$\pm 15$	V
$V_{GSM}$	Pulsed gate-source voltage	$T_j \leq 150^\circ\text{C}$	-	$\pm 20$	V
$I_D$	Continuous drain current	$T_{mb} = 25^\circ\text{C}$ ; $V_{GS} = 5 \text{ V}$	-	69	A
$I_{DM}$	Pulsed drain current	$T_{mb} = 100^\circ\text{C}$ ; $V_{GS} = 5 \text{ V}$	-	48	A
$P_D$	Total power dissipation	$T_{mb} = 25^\circ\text{C}$	-	240	A
$T_j, T_{stg}$	Operating junction and storage temperature	$T_{mb} = 25^\circ\text{C}$	-55	175	°C

<sup>1</sup> It is not possible to make connection to pin 2 of the SOT428 or SOT404 packages.

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Logic level FET

PHP69N03LT, PHB69N03LT, PHD69N03LT

### THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$R_{th\ j\text{-mb}}$	Thermal resistance junction to mounting base		-	-	1.2	K/W
$R_{th\ j\text{-a}}$	Thermal resistance junction to ambient	SOT78 package, in free air SOT404 and SOT428 packages, pcb mounted, minimum footprint	-	60 50	- -	K/W K/W

### ELECTRICAL CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}; T_j = -55^\circ\text{C}$	25	-	-	V
$V_{GS(\text{TO})}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 1 \text{ mA} \quad T_j = 175^\circ\text{C}$	22	-	-	V
$R_{DS(\text{ON})}$	Drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A} \quad T_j = -55^\circ\text{C}$	1	1.5	2	V
$g_{fs}$	Forward transconductance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A} \quad T_j = 175^\circ\text{C}$	0.5	-	-	V
$I_{GSS}$	Gate source leakage current	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 175^\circ\text{C}$	-	-	2.3	V
$I_{DSS}$	Zero gate voltage drain current	$V_{DS} = 25 \text{ V}; I_D = 25 \text{ A} \quad T_j = 175^\circ\text{C}$	12	8.5	12	$\text{m}\Omega$
		$V_{GS} = \pm 5 \text{ V}; V_{DS} = 0 \text{ V} \quad T_j = 175^\circ\text{C}$	-	11	14	$\text{m}\Omega$
		$V_{DS} = 25 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175^\circ\text{C}$	-	-	26	$\text{m}\Omega$
			-	25	-	S
			-	10	100	$\text{nA}$
			-	0.05	10	$\mu\text{A}$
			-	-	500	$\mu\text{A}$
$Q_{g(\text{tot})}$	Total gate charge	$I_D = 20 \text{ A}; V_{DD} = 24 \text{ V}; V_{GS} = 10 \text{ V}$	-	70	-	nC
$Q_{gs}$	Gate-source charge		-	9	-	nC
$Q_{gd}$	Gate-drain (Miller) charge		-	20	-	nC
$t_{d\ on}$	Turn-on delay time	$V_{DD} = 15 \text{ V}; I_D = 25 \text{ A}; V_{GS} = 10 \text{ V}$	-	10	20	ns
$t_r$	Turn-on rise time	$V_{GS} = 10 \text{ V}; R_G = 5 \Omega$	-	50	75	ns
$t_{d\ off}$	Turn-off delay time	Resistive load	-	80	120	ns
$t_f$	Turn-off fall time		-	50	75	ns
$L_d$	Internal drain inductance	Measured tab to centre of die	-	3.5	-	nH
$L_d$	Internal drain inductance	Measured from drain lead to centre of die (SOT78 package only)	-	4.5	-	nH
$L_s$	Internal source inductance	Measured from source lead to source bond pad	-	7.5	-	nH
$C_{iss}$	Input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$	-	1700	-	pF
$C_{oss}$	Output capacitance		-	480	-	pF
$C_{rss}$	Feedback capacitance		-	250	-	pF

TrenchMOS™ transistor  
Logic level FET

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## REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_s$	Continuous source current (body diode)		-	-	69	A
$I_{sm}$	Pulsed source current (body diode)		-	-	240	A
$V_{sd}$	Diode forward voltage	$I_F = 25 \text{ A}; V_{GS} = 0 \text{ V}$ $I_F = 69 \text{ A}; V_{GS} = 0 \text{ V}$	-	0.95 1.0	1.2 -	V
$t_{rr}$ $Q_{rr}$	Reverse recovery time Reverse recovery charge	$I_F = 69 \text{ A}; -dI_F/dt = 100 \text{ A}/\mu\text{s};$ $V_{GS} = -10 \text{ V}; V_R = 25 \text{ V}$	-	65 0.1	- -	ns $\mu\text{C}$

## AVALANCHE LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$W_{DSS}$	Drain-source non-repetitive unclamped inductive turn-off energy	$I_D = 25 \text{ A}; V_{DD} \leq 15 \text{ V};$ $V_{GS} = 5 \text{ V}; R_{GS} = 50 \Omega; T_{mb} = 25^\circ\text{C}$	-	60	mJ

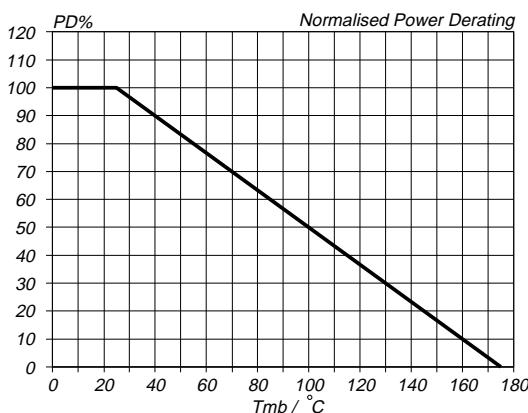


Fig.1. Normalised power dissipation.  
 $PD\% = 100 \cdot P_D/P_{D,25^\circ\text{C}} = f(T_{mb})$

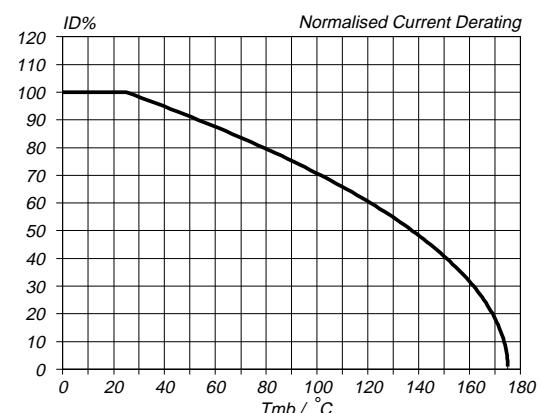
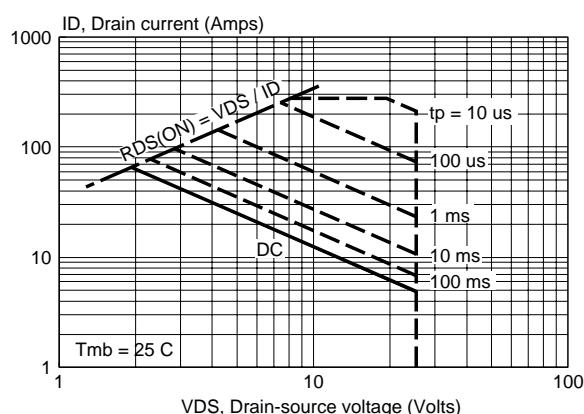


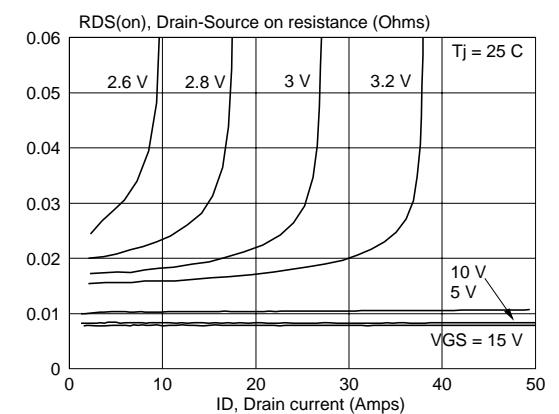
Fig.2. Normalised continuous drain current.  
 $ID\% = 100 \cdot I_D/I_{D,25^\circ\text{C}} = f(T_{mb}); \text{conditions: } V_{GS} \geq 5 \text{ V}$

## TrenchMOS™ transistor Logic level FET

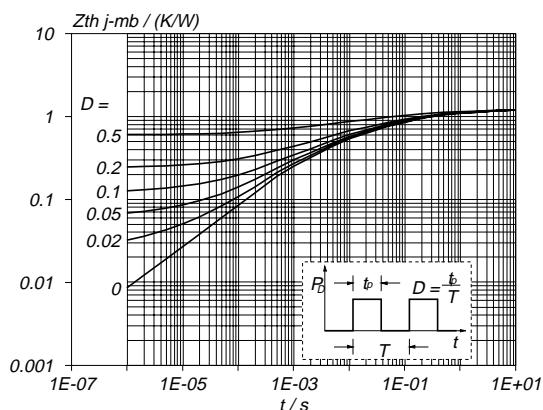
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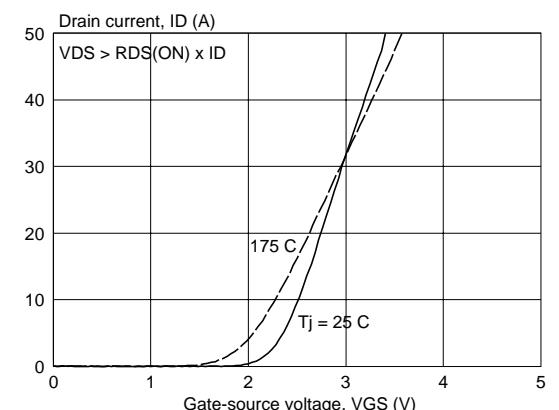
*Fig.3. Safe operating area  
 $I_D$  &  $I_{DM} = f(V_{DS})$ ;  $I_{DM}$  single pulse; parameter  $t_p$*



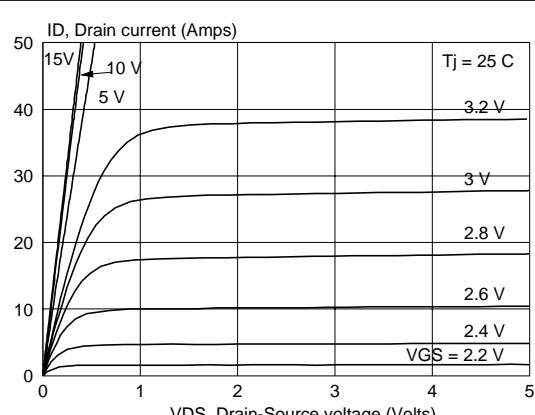
*Fig.6. Typical on-state resistance,  $T_j = 25^\circ C$ .  
 $R_{DS(ON)} = f(I_D)$ ; parameter  $V_{GS}$*



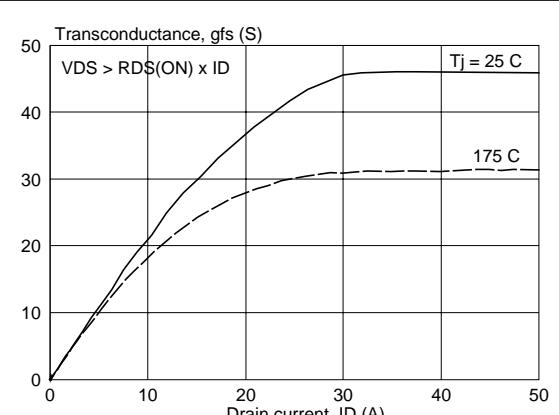
*Fig.4. Transient thermal impedance.  
 $Z_{th\ j-mb} = f(t)$ ; parameter  $D = t_p/T$*



*Fig.7. Typical transfer characteristics.  
 $I_D = f(V_{GS})$ ; conditions:  $V_{DS} = 25 V$ ; parameter  $T_j$*



*Fig.5. Typical output characteristics,  $T_j = 25^\circ C$ .  
 $I_D = f(V_{DS})$ ; parameter  $V_{GS}$*



*Fig.8. Typical transconductance,  $T_j = 25^\circ C$ .  
 $g_{fs} = f(I_D)$*

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## PHP69N03LT, PHB69N03LT, PHD69N03LT

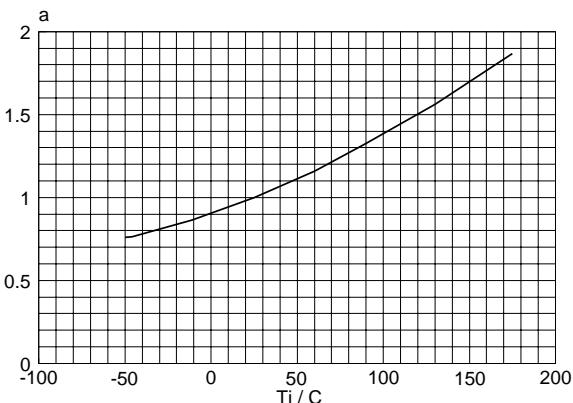


Fig.9. Normalised drain-source on-state resistance.  
 $a = R_{DS(ON)}/R_{DS(ON)25\text{ }^{\circ}\text{C}} = f(T_j)$

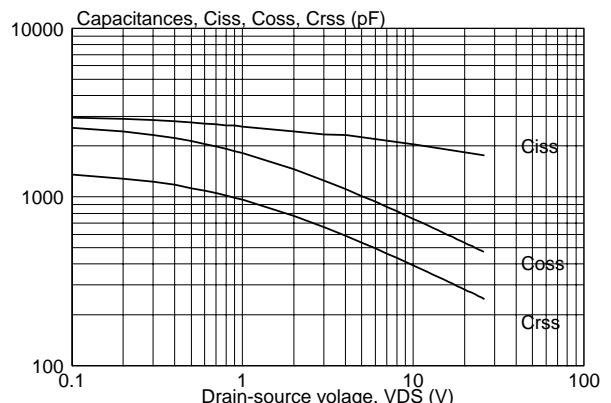


Fig.12. Typical capacitances,  $C_{iss}$ ,  $C_{oss}$ ,  $C_{rss}$ ,  
 $C = f(V_{DS})$ ; conditions:  $V_{GS} = 0 \text{ V}$ ;  $f = 1 \text{ MHz}$

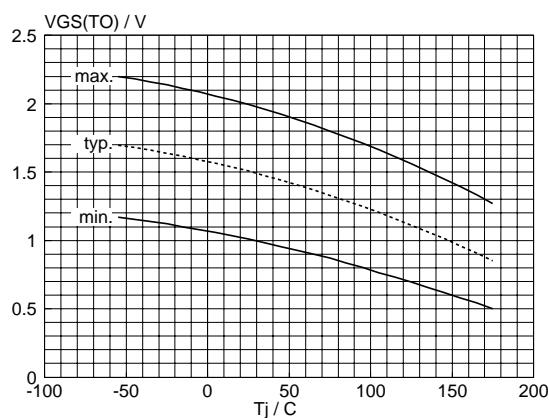


Fig.10. Gate threshold voltage.  
 $V_{GS(TO)} = f(T_j)$ ; conditions:  $I_D = 1 \text{ mA}$ ;  $V_{DS} = V_{GS}$

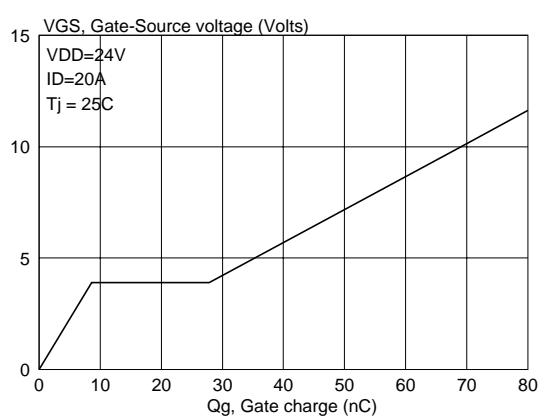


Fig.13. Typical turn-on gate-charge characteristics.  
 $V_{GS} = f(Q_g)$ ; parameter  $V_{DS}$

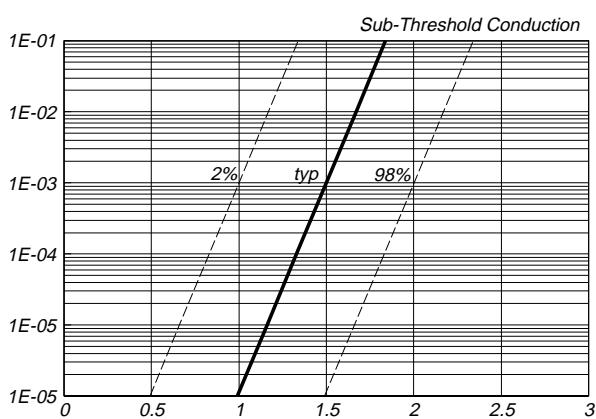


Fig.11. Sub-threshold drain current.  
 $I_D = f(V_{GS})$ ; conditions:  $T_j = 25\text{ }^{\circ}\text{C}$ ;  $V_{DS} = V_{GS}$

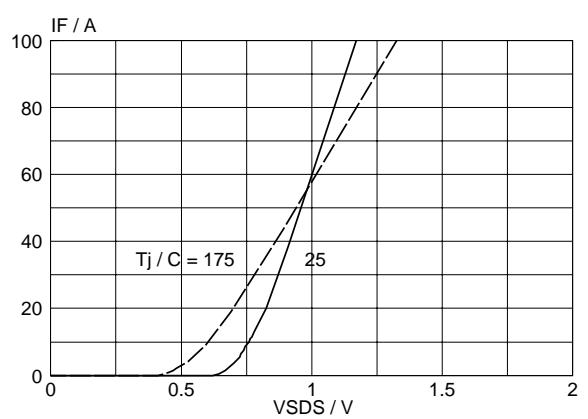


Fig.14. Typical reverse diode current.  
 $I_F = f(V_{SDS})$ ; conditions:  $V_{GS} = 0 \text{ V}$ ; parameter  $T_j$

**TrenchMOS™ transistor  
Logic level FET**

**PHP69N03LT, PHB69N03LT, PHD69N03LT**

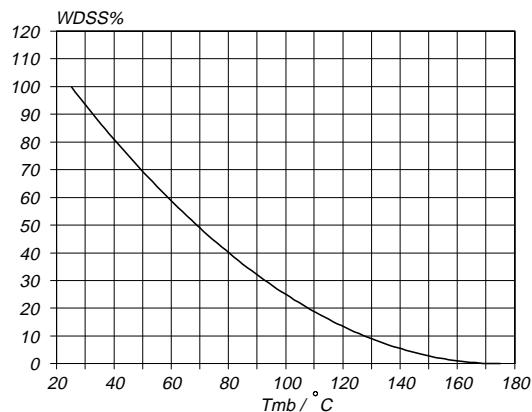


Fig. 15. Normalised avalanche energy rating.  
 $W_{DSS}\% = f(T_{mb})$

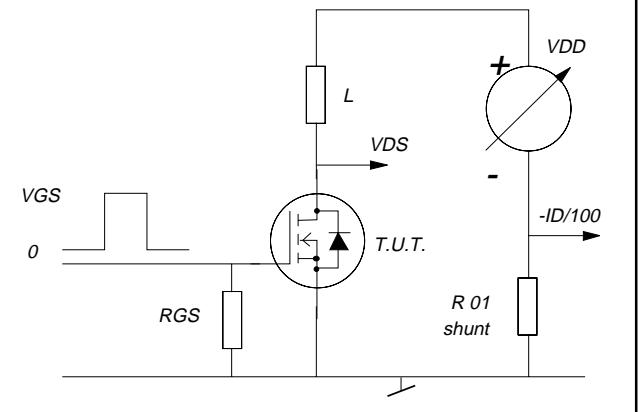


Fig. 16. Avalanche energy test circuit.  
 $W_{DSS} = 0.5 \cdot L I_D^2 \cdot B V_{DSS} / (B V_{DSS} - V_{DD})$

TrenchMOS™ transistor  
Logic level FET

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## MECHANICAL DATA

*Dimensions in mm*

Net Mass: 2 g



Fig.17. SOT78 (TO220AB); pin 2 connected to mounting base.

### Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for SOT78 (TO220) envelopes.
3. Epoxy meets UL94 V0 at 1/8".

TrenchMOS™ transistor  
Logic level FET

PHP69N03LT, PHB69N03LT, PHD69N03LT

## MECHANICAL DATA

*Dimensions in mm*

Net Mass: 1.4 g

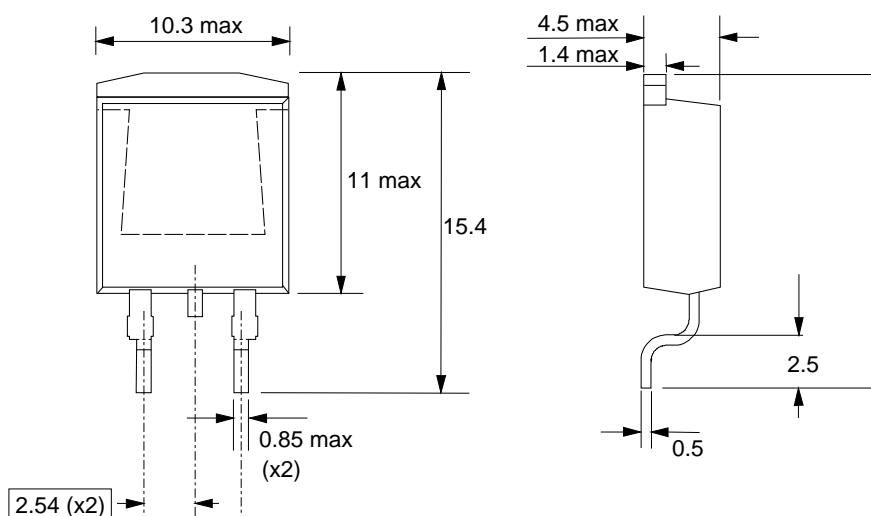


Fig.18. SOT404 : centre pin connected to mounting base.

## MOUNTING INSTRUCTIONS

*Dimensions in mm*

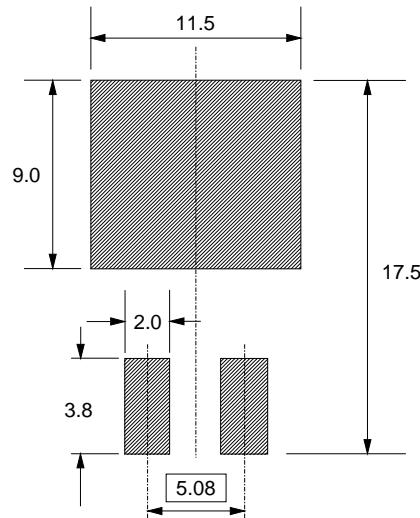


Fig.19. SOT404 : soldering pattern for surface mounting.

### Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Epoxy meets UL94 V0 at 1/8".

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Logic level FET

PHP69N03LT, PHB69N03LT, PHD69N03LT

## MECHANICAL DATA

*Dimensions in mm : Net Mass: 1.4 g*

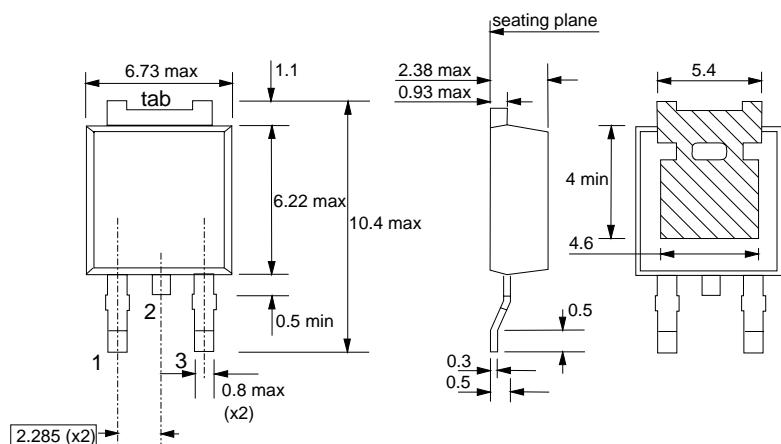


Fig.20. SOT428 : centre pin connected to mounting base.

## MOUNTING INSTRUCTIONS

*Dimensions in mm*

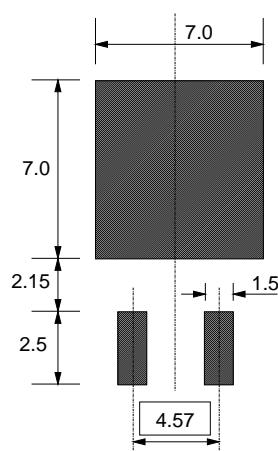


Fig.21. SOT428 : soldering pattern for surface mounting.

### Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Epoxy meets UL94 V0 at 1/8".

TrenchMOS™ transistor  
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## DEFINITIONS

<b>Data sheet status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	
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